

Search Notes

Application/Control No.

10/617,171

Examiner

Tianjie Chen

Applicant(s)/Patent under
Reexamination

JEONG, KI-TAG

Art Unit

2652

SEARCHED

Class	Subclass	Date	Examiner
360	264.7		
	264.8		
	265		
	264.2		
	265.1		
	265.6		
310	12	5/15/2005	TJ

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east Report	5/15/2005	TJ